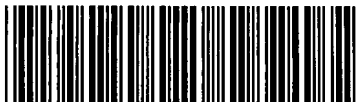


**Search Notes**

Application/Control No.

10/543,076

Examiner

Bin Shen

Applicant(s)/Patent under  
Reexamination

BACHER ET AL.

Art Unit

1655

**SEARCHED**

Class	Subclass	Date	Examiner
NA	NA	9/20/2006	BS

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STN/WEST-see printout.	9/20/2006	BS
Priority document checked.	9/20/2006	BS
Inventor name searched.	9/20/2006	BS
SEQ ID checked.	9/20/2006	BS